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**ADRIATICO CONFERENCE ON
FOURIER OPTICS AND
HOLOGRAPHY**

6 - 9 March 1990

SPECKLE PHENOMENA

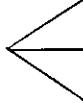
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Speckle Phenomena

coherent illumination

Speckle 

Originally, speckle appears as noise causing degradation in the recording of a holographic image.

Denis Gabor: 'The novelty in holography is speckle noise. This has really nothing to do with holography, it is a consequence of coherence. It has an special standing among noise phenomena because it is not really a noise, but unwanted information....'.

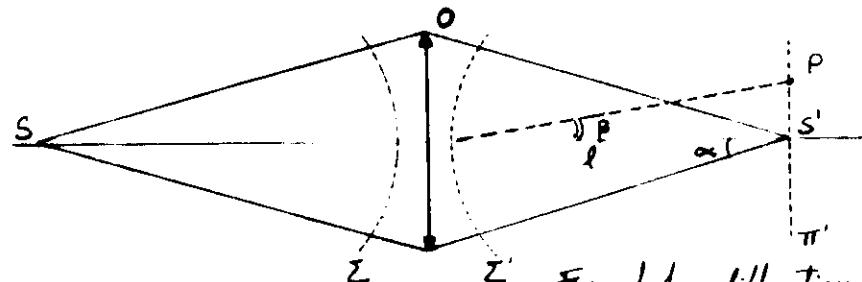
Speckle was sensitive to movements (moving diffuser).

Burch and Tokarski [Optica Acta, 15, pp. 106]

- Brief physical introduction to speckle.
- Roughness.
- Image optical operations.
- Speckle correlation (the joint transform correlator).
- Speckle and the display of coherence.
- Speckle and periodicities.
- Speckle as 3-D display.
- Velocimetry by using speckle patterns.

Physical Introduction

Point source image

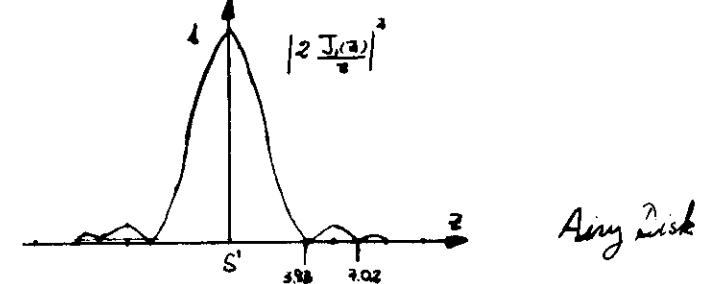


Fraunhofer diffraction pattern
The structure is calculated by the Huygens-Fresnel principle \rightarrow Fourier transform (spectrum)

Example: limiting circular aperture, the amplitude is given by

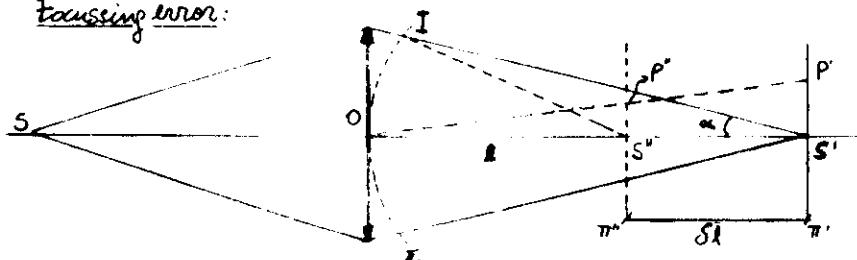
$$A(\beta) = \frac{2 J_1(k a \beta)}{k a \beta} \quad (1) \quad \begin{aligned} 2a &= \text{diameter} \\ k &= 2\pi/\lambda \end{aligned}$$

The resulting intensity pattern $|A(\beta)|^2$ is



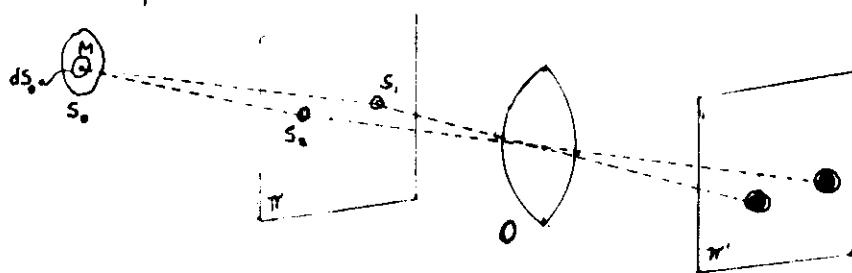
From the Bessel function, the angular radius of the first ring is $\beta = \frac{1.22}{2a}$

Focusing error:

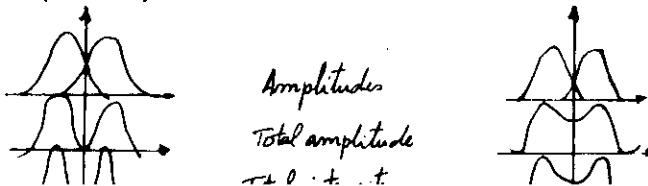


At focus all vibrations are in phase, at S'' not. The maximum optical path difference at S'' is $\Delta = IS'' - OS''$ or $\Delta = \delta l \alpha^2/2$. We define S'' identical to S' when Δ does not exceed 1, that is $\delta l \ll 2\alpha^2$.

Two monochromatic point sources

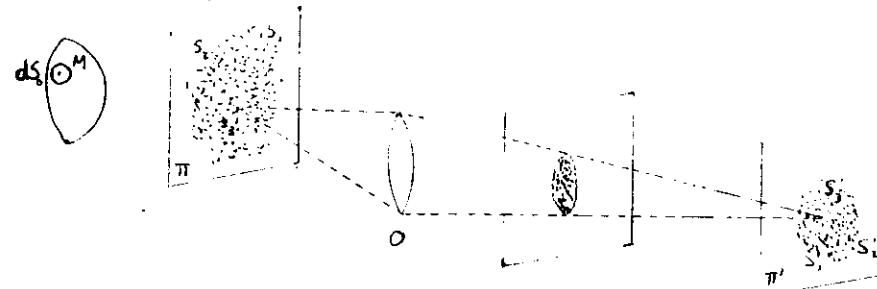


The optical path difference is $\Delta = MS_1 - MS_2$, and the phase difference $\phi = 2\pi\Delta/\lambda$. When S_1 and S_2 are illuminated by dS_o are said to be coherent. The phenomenon in π' depends on ϕ [the amplitudes must be added]. If $\phi = \pi$, both amplitudes are subtracted. By taking another dS'_o , phase change, but diffraction image not, and intensity will change. If S_1 and S_2 are simultaneously illuminated by dS_o and dS'_o , there is no phase relationship between them, they are incoherent, and in such case the intensities of the diffraction images must be added.



Consider now the operation is performed for all dS_o on S_o : intensity distribution at π' is equal to the one obtained when the two diffraction images are added. When illuminated by an extended source S_o , and S_2 behave like two incoherent sources, the intensity is found by adding the intensities of the two diffraction images produced separately by S_1 and S_2 .

Large number of point sources distributed at random



Each aperture diffract the light as coherent light sources, giving at π' an tiny disk. All amplitudes are added taking into account the phase relationships. A quite complex structure is obtained, the smallest spot having a diameter equal to that of the diffraction spot of lens O. This granular structure is called speckle. As dS_o is increased, the elements behave as quasi-coherent sources, decreasing the contrast of speckles. For the whole source S_o , the contrast tend to zero and speckles disappears, being the source incoherent.

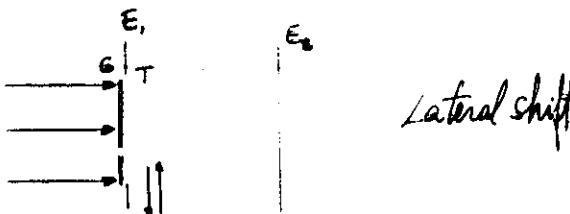
Fresnel and Fraunhofer diffraction in 3-D



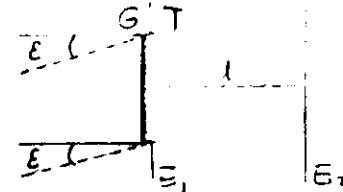
Intensity at M results from the contribution of all points belonging to T . The optical path difference $MA - MC = d = \alpha^2/2l$, then the phase values are between 0 and Δ . A variation δl cause a phase difference by $\alpha^2 \delta l / 2l$. If M and M' must be the same, this change must be smaller than 1 , if $\alpha = d/l \Rightarrow \delta l \ll 2l/\alpha^2$ \oplus

Under this condition the Fresnel pattern at E_3 is similar to the one at E_2 . It is also shown that the structure changes more slowly as the distance $E_1 E_2$ increases. When δl can take practically any value we pass to the domain of Fraunhofer diffraction. If a screen with small holes is placed at T , light will be diffracted and spread out at E_2 , then another speckle pattern will appear. Under \oplus , a change to E_3' produce a scale factor. According to this, speckle patterns are classified as Fresnel-type for intervals $E_1 E_2$ with finite length, and Fraunhofer-type when $E_1 E_2$ increases indefinitely. The same is valid for a diffuse reflecting object, where the surface irregularities give rise to a phenomenon similar to the small holes, with wider spread as smaller the irregularities. In a ground glass in T , the smallest speckle diameter is given by $\varepsilon = l^2/a$, independent of the structure of the object. The spatial distribution depends on such structure.

Speckle shifting

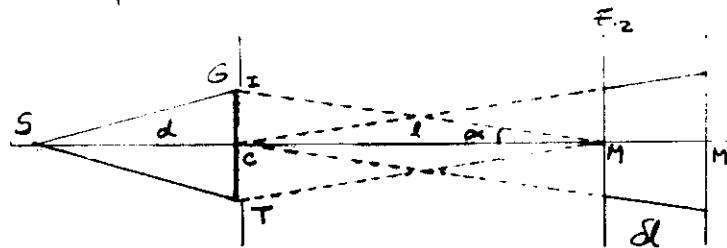


In the case the beam converges to E without G ("Fresnel plane"), no alteration is seen when moving G . A constant phase is added and the intensity distribution remains the same. The same holds for a reflecting diffuse object.



orientation of the beam

The speckle pattern remains identical only translated $E1$



Axial translation

If $\delta l \ll 2l/\alpha$ is satisfied \rightarrow two correlated speckles (scale factor)
Also by $\Delta\lambda$, or illuminating a diffuser with another speckle pattern.
Summarizing: a movement of $G \rightarrow$ scale change, depending on the amount of the displacement of the object.

The fundamental experiment of Burch and Tokarski

$D(\eta, s)$ normal speckle distribution

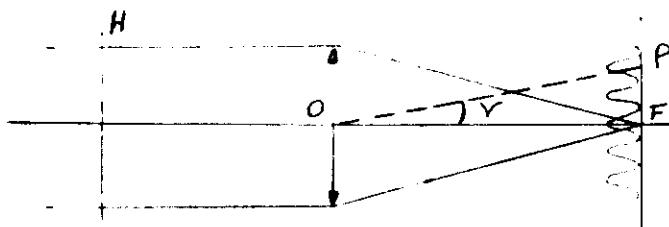
Double exposure $H +$ Displacement s

The recorded intensity is $D(\eta, s) + D(\eta, s-s_0)$

or $D(\eta, s) \oplus [D(\eta, s) + D(\eta, s-s_0)] +$

The intensity transmitted after development is proportional to $+ \dots$

Both are copied on H illuminated by speckle + S_0



$$\text{At focal plane } \tilde{D}(u, v) [1 + \exp(i\pi v S_0/\lambda)] \quad \tilde{D} = FT[D]$$

$$I \propto |\tilde{D}(u, v)|^2 \cos^2(\frac{\pi v S_0}{\lambda}) \quad (\text{speckle background})$$

orientation of fringes give information about the direction of the movement.

ESPI = Also data can be collected by a T.V. camera and electronically processed [recorder]

Roughness

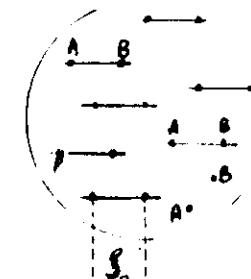
Mechanical profilometer - stylus $V(h)$

Drawbacks
1: contact method (damage surface)
2: 1-D information

Optical techniques - contrast of speckles - statistical properties of speckle intensity variations

Optical processing

A, B photographs, A-B is required to remove features that remains unchanged



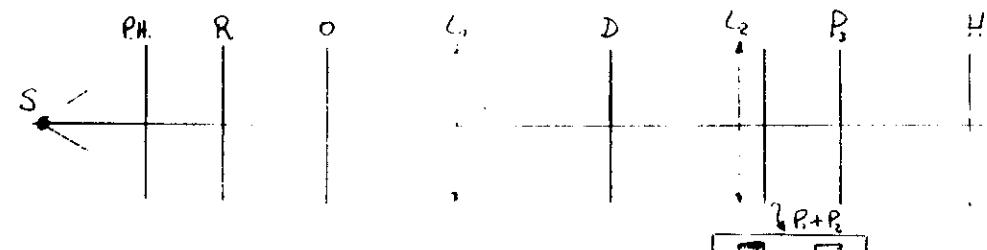
Areas with identical grains give rise to Young fringes. Slit filters the information.

Optical Operations

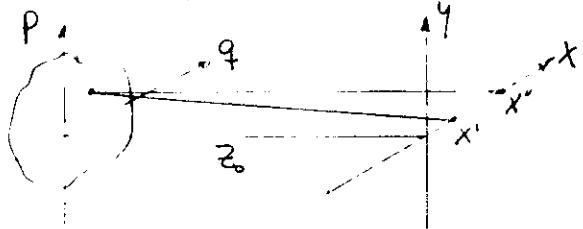
Young fringes modulated speckle pattern: multiple apertures (shear)



Array of polarizers (1-independent) - 50% operations (partially coherent white light)



40 Speckle patterns and optical periodicities



Coherent light propagation \rightarrow diffraction. Temporal coherence \rightarrow spectral profile of the source. According to VC-2, the mutual intensity (degree of spatial coherence)

$$J(x', x'') = \exp(i\alpha) \text{FT}[I(p, q)]$$

$$\alpha = k(x'^2 - x''^2)/2z_0 \quad I(p, q) = \text{intensity function of the source}$$

Spatial periodic source: multiple exposed speckle pattern (shifted s)

$$\bar{I}(p, q) = I_0(p, q) * \sum_m \delta(q - ms) \quad ; \quad I_0(p, q) = \text{single speckle pattern}$$

$$(A) \quad J(x, x') = \frac{I_0}{(12)} \cdot \exp\left(\frac{x^2 - x'^2}{\lambda z_0}\right) \sum_m \exp\left(\frac{2\pi imx's}{\lambda z_0}\right) \quad \text{on a plane, at } z_0$$

If a grating is placed at G : $g(x') = P \sum_m \exp(2\pi imx'/d)$ (B)
 d = period of grating

By comparing (A) and (B), the slits of grating are coherently illuminated if:

$$z_0 = \left(\frac{m}{m}\right) \frac{sd}{\lambda}$$